IN THE CLAIMS

- (Currently amended) A capacitor formed on a semiconductor substrate, the capacitor comprising:
 - a first electrode region of a first stair-stepped metal layer;
 - a contact region that is a part of the first stair-stepped metal layer;
- a second electrode of a second metal layer that is closer to the substrate than the first stair-stepped metal layer:
- a dielectric layer intermediate the first electrode region and the second electrode, the dielectric layer including a contact opening therethrough in the vicinity of the contact region,

wherein the first stair-stepped metal layer in a stair-stepped region thereof steps laterally and downwardly across the dielectric layer and into and at least partway laterally across the contact opening; and

a wire electrically coupled to and in contact with a bottom surface of the contact region of the first stair-stepped metal layer through the contact opening in the dielectric layer,

wherein the first electrode region is electrically coupled to the wire through the contact opening in the dielectric layer.

- (Original) The capacitor of claim 1 wherein the wire is formed of a third metal layer that is closer to the substrate than the second metal layer.
- (Original) The capacitor of claim 1 wherein the wire is formed of the second metal layer.
 - 4. (Cancelled)
- (Previously presented) The capacitor of claim 1 wherein the contact opening comprises a plurality of separate contact holes.
 - 6. (Original) The capacitor of claim 1 wherein the wire has a planarized top surface.

- (Original) The capacitor of claim 6 wherein the wire comprises a damascene layer.
 - 8-11. (Cancelled)
 - 12. (Currently amended) A metal-insulator-metal capacitor, comprising:
- a wire layer formed in a first metal layer, the wire layer including a first electrode contacting line;
 - a bottom electrode formed in a second metal laver:
- wherein the wire layer comprises a second electrode contacting line, and wherein the second electrode contacting line is coupled to a bottom surface of the bottom electrode;
- a top electrode formed in a third metal layer, the top electrode disposed over the bottom electrode:
 - a dielectric layer separating the bottom electrode from the top electrode;
- a contact formed between the first electrode contacting line and a bottom side of the top electrode: and
 - a second contact located on a top side of the bottom electrode,
- wherein a portion of the bottom surface of the bottom electrode directly contacts a top surface of the second electrode contacting line and not through a contact hole, and
- wherein a portion of the bottom surface of the bottom electrode directly contacts a top surface of the second electrode contacting line and not through a contact hole.
- 13. (Previously presented) The capacitor of claim 12 wherein the bottom electrode couples to the second electrode contacting line through a contact hole in an insulation layer.
- (Previously presented) The capacitor of claim 12 wherein the first and second electrode contacting lines each have a planarized top surface.
- 15. (Original) The capacitor of claim 14 wherein the first and second contacting lines are planarized by a damascene process.

- (Original) The capacitor of claim 14 wherein the first and second contacting lines are planarized by a CMP process performed on an interlayer dielectric layer.
- (Previously presented) The capacitor of claim 12 wherein a top surface of the first and second contacting lines are formed in a process other than planarization.
 - 18. (Cancelled)
- (Previously presented) The capacitor of claim 12, wherein the second contact extends away from a substrate farther than the third metal layer.
- 20. (Previously presented) A metal-insulator-metal capacitor, comprising: a first metal layer including a bottom electrode and an electrode contacting line; a top stair-stepped electrode formed in a second metal layer, the top electrode disposed over the bottom electrode;
 - a dielectric layer separating the bottom electrode from the top electrode;
- a contact formed between the electrode contacting line and a bottom side of the top electrode; and
 - a second contact located on a top side of the bottom electrode.
 - 21. (Previously presented) A metal-insulator-metal capacitor, comprising:
 - a first metal layer including a bottom electrode and an electrode contacting line;
- a top electrode formed in a second metal layer, the top electrode disposed over the bottom electrode:
 - a dielectric layer separating the bottom electrode from the top electrode;
- a contact formed between the electrode contacting line and a bottom side of the top electrode; and
 - a second contact located on a top side of the bottom electrode,
- wherein the top electrode couples to the electrode contacting line through a contact hole in the dielectric layer.

- (Original) The capacitor of claim 21, wherein the contact hole comprises a plurality of separate holes.
 - 23. (Cancelled)
- (Currently amended) The capacitor of claim 21, wherein the second contact extends away from aff the]] substrate farther than the second metal layer.
- 25. (Previously presented) The capacitor of claim 21 wherein the bottom electrode and the electrode contacting line each have a planarized top surface.
- 26. (Original) The capacitor of claim 25 wherein the bottom electrode and the electrode contacting line are planarized by a damascene process.
- (Original) The capacitor of claim 25 wherein the bottom electrode and the electrode contacting line are planarized by a CMP process performed on an interlayer dielectric layer.
- 28. (Previously presented) The capacitor of claim 21 wherein the bottom electrode and the electrode contacting line are formed in a process other than planarization.
 - 29-51. (Cancelled)
 - 52. (Previously presented) A metal-insulator-metal capacitor, comprising:
- a wire layer formed in a first metal layer, the wire layer including a first electrode contacting line;
 - a bottom electrode formed in a second metal layer;
- a stair-stepped top electrode formed in a third metal layer, the top electrode disposed over the bottom electrode:
 - a dielectric layer separating the bottom electrode from the top electrode; and

a contact formed between the electrode contacting line and a bottom side of the top electrode, wherein the top electrode couples to the first electrode contacting line through a contact hole in the dielectric layer, the contact hole having a vertical:horizontal aspect ratio of less than about 1:1.